

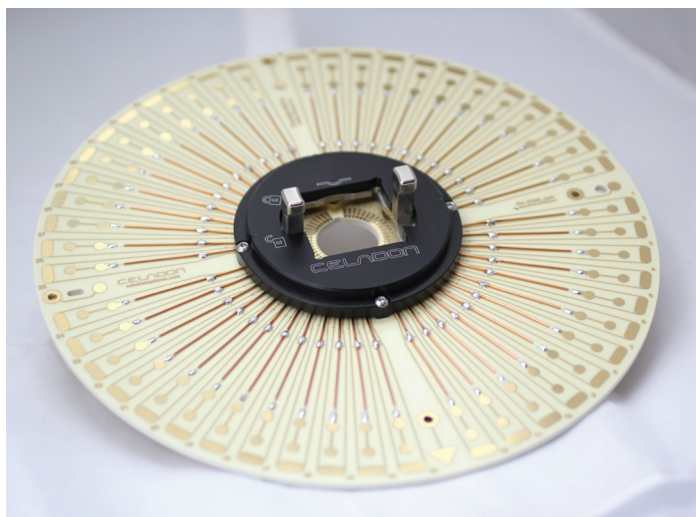
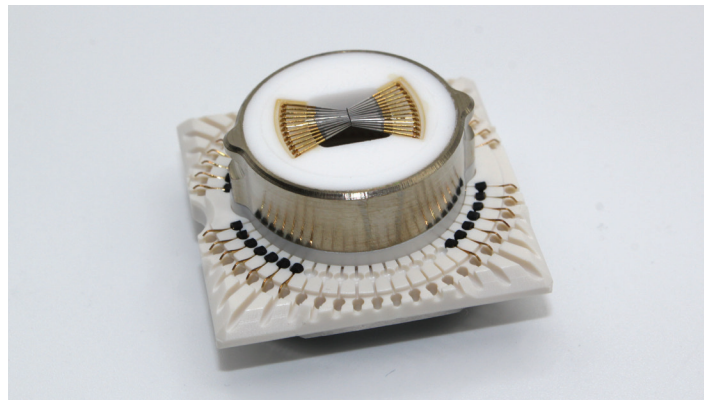
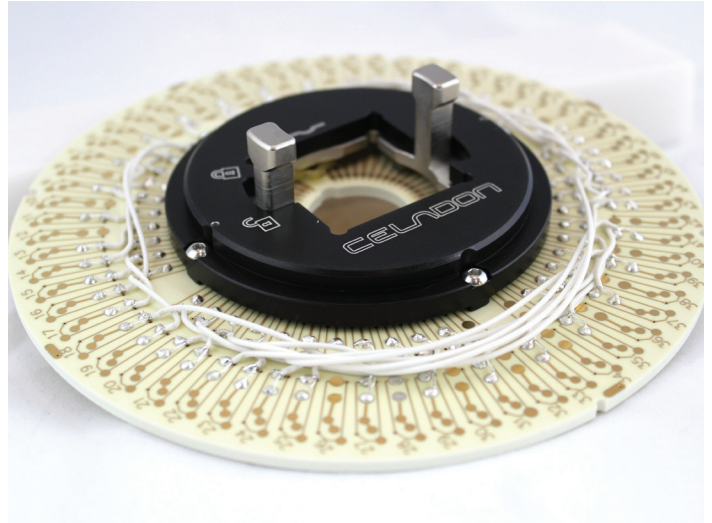
ATTOFAST™ TECHNOLOGY

VC20 ATTOFAST™

Low-Leakage, Fast Settling, Low Capacitance Modular Probe Card

The widely used VC20™ probe card, the probe card of choice for most modeling, characterization and reliability labs and production parametric probe floors, has a new sister product called the VC20EAF™. Celadon's proven AttoFast™ technology has been integrated into the VC20™ probe card resulting in superior leakage performance, low and more stable capacitance while retaining the flexibility of a modular probe card system.

Both designs of the VC20™ are compatible with direct dock testers including Keithley and Agilent/Keysight Parametric Testers and with cabled-out solutions to support rack and stack testing using the Celadon 45E™ cabled-out probe card adaptor in an analytical manual or semi-automatic prober.



ATTOFAST™
TECHNOLOGY
IN THE POPULAR
VC20™ PROBE
CARD FORMAT